Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/784,950	KAMIYA ET AL.	
Examiner	Art Unit	
Patrick H. Mackey	3651	

	SEARCHED		
Class	Subclass	Date	Examiner
271	220		
	221		
	222		
270	58.11		
	58.12		
	58.16		
	58.17	7/15/2005	РНМ
Above	Updated	10/11/2005	РНМ
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	1		

SEARC (INCLUDING SEA	H NOTES ARCH STRATEG	SY)
	DATE	EXMR
Plus Search	7/15/2005	5 PHM
Text Search	7/15/2005	5 РНМ